Search Notes



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	SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated class/subclass search of 7/30/07	4/16/08	B. Deppe		
Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT IBM-TDB)	4/16/08	B. Deppe		
Inventor name search	4/16/08	B. Deppe		
Text search (USPAT; US-PGPUB)	4/17/08	B. Deppe		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
375	147, 316, 340	4/17/08	B. Deppe		
370	320, 335, 342, 441, 479	4/17/08	B. Deppe		
455	561	4/17/08	B. Deppe		

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